Search Notes					

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Application No.	Applicant(s)	
10/620,977	TIEN, FENG-YI	
Examiner	Art Unit	

Raleigh Chiu

SEARCHED			
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Class	Subclass	Date	Examiner
273	108.1		
	126R		
	126A	5/27/2004	RWC
updated	as above	9/29/2004	RWC
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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
same as	above	9/29/2004	RWC
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
PALM inventor name search	5/27/2004	RWC